



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AO4852**

**60V Dual N-Channel MOSFET**

### General Description

The AO4852 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. As a pair these MOSFETs operate very efficiently in Push Pull and Bridge topologies.

### Product Summary

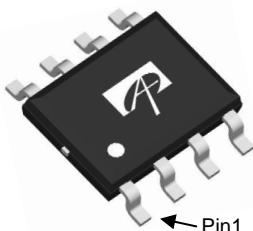
$V_{DS}$  (V) = 60V  
 $I_D$  = 3.5A ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 90mΩ ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 105mΩ ( $V_{GS}$  = 4.5V)

100% UIS Tested  
 100%  $R_g$  Tested

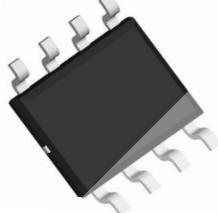


SOIC-8

Top View

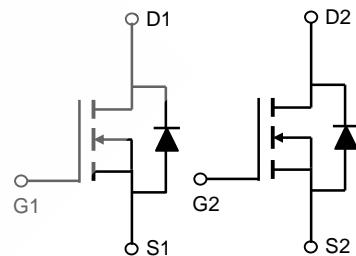


Bottom View



Top View

S2 1 D2  
 G2 2 D2  
 S1 3 D1  
 G1 4 D1



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum		Units
		10 Sec	Steady State	
Drain-Source Voltage	$V_{DS}$	60		V
Gate-Source Voltage	$V_{GS}$	$\pm 20$		V
Continuous Drain Current <sup>A</sup>	$I_D$	3.5	3	A
		2.8	2.4	
Pulsed Drain Current <sup>B</sup>	$I_{DM}$	20		
Power Dissipation	$P_D$	2	1.4	W
		1.3	0.9	
Avalanche Current <sup>B</sup>	$I_{AR}$	8		A
Repetitive avalanche energy 0.3mH <sup>B</sup>	$E_{AR}$	9.6		mJ
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150		°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	48	62.5	°C/W
Maximum Junction-to-Ambient <sup>A</sup> Steady-State		74	90	°C/W
Maximum Junction-to-Lead <sup>C</sup>	$R_{\theta JL}$	33	40	°C/W

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	60			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS}=60\text{V}, V_{GS}=0\text{V}$			1	$\mu\text{A}$
		$T_J=55^\circ\text{C}$			5	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			100	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.7	2.3	2.6	V
$I_{D(\text{ON})}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	20			A
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=3\text{A}$		79	90	$\text{m}\Omega$
		$T_J=125^\circ\text{C}$		146	159	
$g_{FS}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=3\text{A}$		15		S
$V_{SD}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.8	1	V
$I_{SM}$	Pulsed Body-Diode Current <sup>B</sup>				20	A
$I_S$	Maximum Body-Diode Continuous Current				2.5	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=30\text{V}, f=1\text{MHz}$		372	450	pF
$C_{oss}$	Output Capacitance			31		pF
$C_{rss}$	Reverse Transfer Capacitance			17		pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		1.7	2.6	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=30\text{V}, I_D=3\text{A}$		7.1	9.2	nC
$Q_g(4.5\text{V})$	Total Gate Charge			3.6		nC
$Q_{gs}$	Gate Source Charge			1		nC
$Q_{gd}$	Gate Drain Charge			2		nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=30\text{V}, R_L=10\Omega, R_{\text{GEN}}=3\Omega$		4.1	5.3	ns
$t_r$	Turn-On Rise Time			2.1		ns
$t_{D(\text{off})}$	Turn-Off Delay Time			15		ns
$t_f$	Turn-Off Fall Time			2.1		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=3\text{A}, dI/dt=100\text{A}/\mu\text{s}$		23.4	29	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=3\text{A}, dI/dt=100\text{A}/\mu\text{s}$		23.2		nC

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using < 300  $\mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

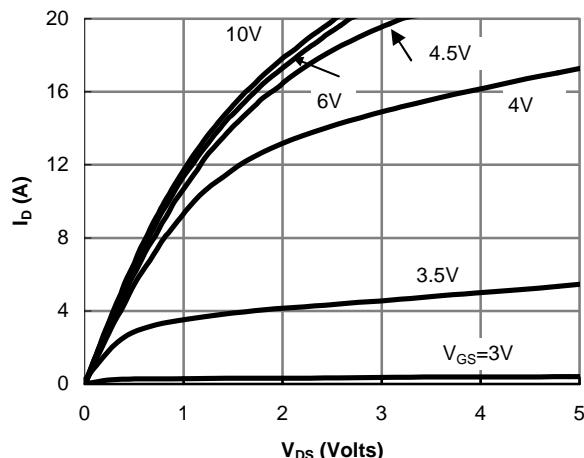


Fig 1: On-Region Characteristics

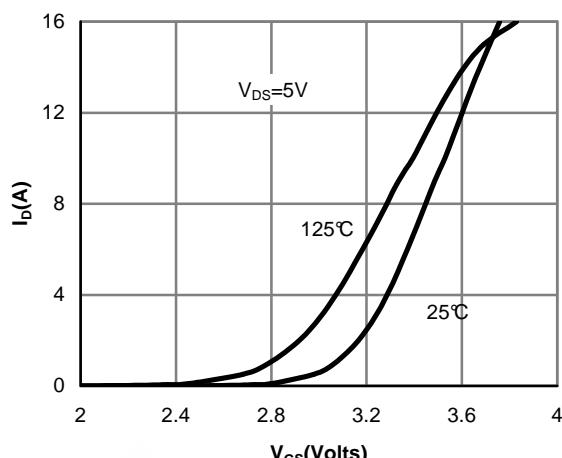


Figure 2: Transfer Characteristics

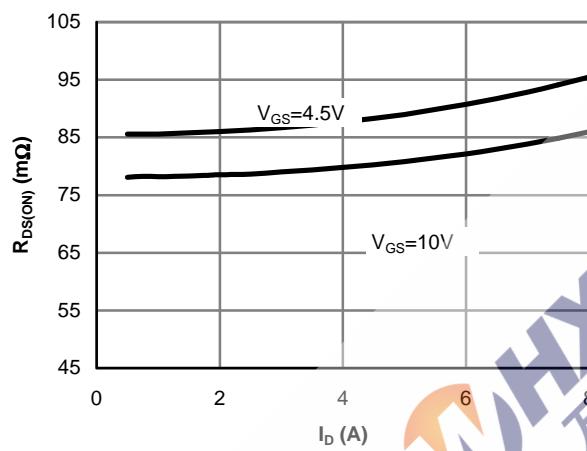


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

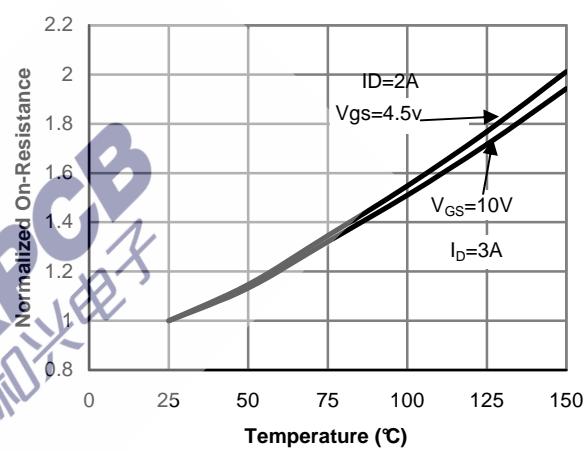


Figure 4: On-Resistance vs. Junction Temperature

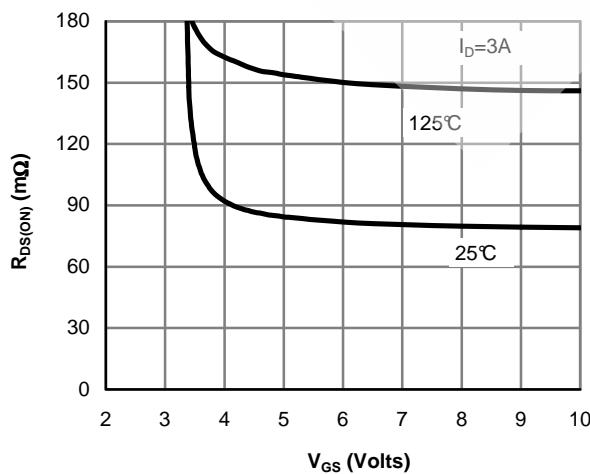


Figure 5: On-Resistance vs. Gate-Source Voltage

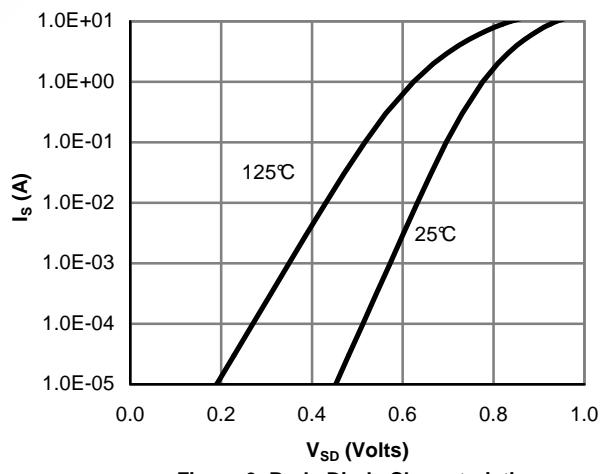


Figure 6: Body-Diode Characteristics

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